

MOSFETs Silicon P-/N-Channel MOS

# SSM6L56FE

#### 1. Applications

· High-Speed Switching

#### 2. Features

- (1) 1.5-V drive
- (2) Low drain-source on-resistance

#### Q1 N-channel:

 $R_{\mathrm{DS(ON)}}$  = 235 m $\Omega$  (max) (@V\_{\mathrm{GS}} = 4.5 V,  $I_{\mathrm{D}}$  = 800 mA)

 $R_{DS(ON)}$  = 300 m $\Omega$  (max) (@V<sub>GS</sub> = 2.5 V,  $I_D$  = 600 mA)

 $R_{DS(ON)} = 480 \text{ m}\Omega \text{ (max) (@V_{GS} = 1.8 V, I_D = 200 mA)}$ 

 $R_{DS(ON)}$  = 840 m $\Omega$  (max) (@V\_{GS} = 1.5 V,  $I_D$  = 50 mA)

#### Q2 P-channel:

 $R_{DS(ON)}$  = 390 m $\Omega$  (max) (@V<sub>GS</sub> = -4.5 V,  $I_D$  = -800 mA)

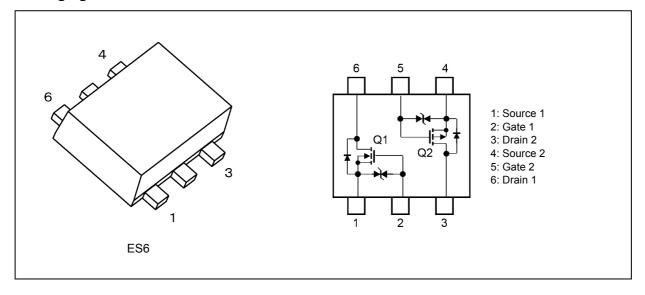
 $R_{\rm DS(ON)}$  = 480 m $\Omega$  (max) (@V<sub>GS</sub> = -2.5 V,  $I_{\rm D}$  = -500 mA)

 $R_{\rm DS(ON)}$  = 660 m $\Omega$  (max) (@V<sub>GS</sub> = -1.8 V,  $I_{\rm D}$  = -200 mA)

 $R_{DS(ON)}$  = 900 m $\Omega$  (max) (@V<sub>GS</sub> = -1.5 V,  $I_D$  = -100 mA)

 $R_{DS(ON)} = 4000 \text{ m}\Omega \text{ (max) (@V_{GS} = -1.2 V, I_D = -10 mA)}$ 

#### 3. Packaging and Internal Circuit





#### 4. Absolute Maximum Ratings (Note)

#### 4.1. Q1 Absolute Maximum Ratings (Unless otherwise specified, T<sub>a</sub> = 25 °C)

Characteristics		Symbol	Rating	Unit
Drain-source voltage		$V_{DSS}$	20	V
Gate-source voltage		$V_{GSS}$	±8	
Drain current (DC)	(Note 1)	I <sub>D</sub>	800	mA
Drain current (pulsed)	(Note 1)	I <sub>DP</sub>	1600	

Note 1: Ensure that the channel temperature does not exceed 150 °C.

#### 4.2. Q2 Absolute Maximum Ratings (Unless otherwise specified, T<sub>a</sub> = 25 °C)

Characteristics		Symbol	Rating	Unit
Drain-source voltage		V <sub>DSS</sub>	-20	V
Gate-source voltage		V <sub>GSS</sub>	±8	
Drain current (DC)	(Note 1)	I <sub>D</sub>	-800	mA
Drain current (pulsed)	(Note 1)	I <sub>DP</sub>	-1600	

Note 1: Ensure that the channel temperature does not exceed 150 °C.

# 4.3. Absolute Maximum Ratings (Unless otherwise specified, T<sub>a</sub> = 25 °C) (Q1, Q2 Common)

Characteristics	Symbol	Rating	Unit	
Power dissipation	(Note 1)	$P_D$	150	mW
Power dissipation	(Note 2)		250	
Channel temperature		T <sub>ch</sub>	150	°C
Storage temperature	-	T <sub>stg</sub>	-55 to 150	

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 1: Device mounted on an FR4 board.(total rating)

(25.4 mm  $\times$  25.4 mm  $\times$  1.6 mm, Cu pad: 0.135 mm²  $\times$  6)

Note 2: Device mounted on an FR4 board.(total rating)

 $(25.4 \text{ mm} \times 25.4 \text{ mm} \times 1.6 \text{ mm}, \text{ Cu pad: } 645 \text{ mm}^2)$ 

Note: The MOSFETs in this device are sensitive to electrostatic discharge. When handling this device, the worktables, operators, soldering irons and other objects should be protected against anti-static discharge.

Note: The channel-to-ambient thermal resistance, R<sub>th(ch-a)</sub>, and the drain power dissipation, P<sub>D</sub>, vary according to the board material, board area, board thickness and pad area. When using this device, be sure to take heat dissipation fully into account.

2019-08-01



#### 5. Electrical Characteristics

### 5.1. Q1 Static Characteristics (Unless otherwise specified, Ta = 25 °C)

Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage current		I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 6 \text{ V}$	_	_	±1	μА
Drain cut-off current		I <sub>DSS</sub>	V <sub>DS</sub> = 16 V, V <sub>GS</sub> = 0 V	_	_	1	
Drain-source breakdown voltage		$V_{(BR)DSS}$	I <sub>D</sub> = 1 mA, V <sub>GS</sub> = 0 V	20	_		V
Drain-source breakdown voltage	(Note 1)	$V_{(BR)DSX}$	I <sub>D</sub> = 1 mA, V <sub>GS</sub> = -5 V	15	_	_	
Gate threshold voltage	(Note 2)	$V_{th}$	V <sub>DS</sub> = 3 V, I <sub>D</sub> = 1 mA	0.4	_	1.0	
Drain-source on-resistance	(Note 3)	R <sub>DS(ON)</sub>	I <sub>D</sub> = 800 mA, V <sub>GS</sub> = 4.5 V	_	186	235	mΩ
			I <sub>D</sub> = 600 mA, V <sub>GS</sub> = 2.5 V	_	230	300	
			I <sub>D</sub> = 200 mA, V <sub>GS</sub> = 1.8 V	_	290	480	
			I <sub>D</sub> = 50 mA, V <sub>GS</sub> = 1.5 V	_	360	840	
Forward transfer admittance	(Note 3)	Y <sub>fs</sub>	V <sub>DS</sub> = 3 V, I <sub>D</sub> = 200 mA	_	1.4		S

Note 1: If a reverse bias is applied between gate and source, this device enters  $V_{(BR)DSX}$  mode. Note that the drain-source breakdown voltage is lowered in this mode.

Note 2: Let  $V_{th}$  be the voltage applied between gate and source that causes the drain current  $(I_D)$  to below (1 mA for this device). Then, for normal switching operation,  $V_{GS(ON)}$  must be higher than  $V_{th}$ , and  $V_{GS(OFF)}$  must be lower than  $V_{th}$ . This relationship can be expressed as:  $V_{GS(OFF)} < V_{th} < V_{GS(ON)}$ .

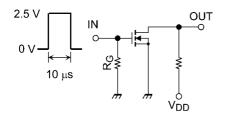
Take this into consideration when using the device.

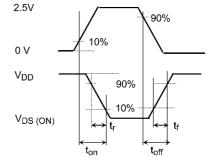
Note 3: Pulse measurement.

#### 5.2. Q1 Dynamic Characteristics (Unless otherwise specified, T<sub>a</sub> = 25 °C)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Input capacitance	C <sub>iss</sub>	V <sub>DS</sub> = 10 V , V <sub>GS</sub> = 0 V,	_	55	_	pF
Reverse transfer capacitance	C <sub>rss</sub>	f = 1 MHz	_	6	_	
Output capacitance	C <sub>oss</sub>		_	16	_	
Switching time (turn-on time)	t <sub>on</sub>	V <sub>DD</sub> = 10 V, I <sub>D</sub> = 200 mA,	_	5.5	_	ns
Switching time (turn-off time)	t <sub>off</sub>	$V_{GS}$ = 0 to 2.5 V, $R_{G}$ = 50 $\Omega$	_	8.5		

#### 5.3. Q1 Switching Time Test Circuit





**Switching Time Test Circuit** 

Input Waveform/Output Waveform

## 5.4. Q1 Gate Charge Characteristics (Unless otherwise specified, T<sub>a</sub> = 25 °C)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Total gate charge (gate-source plus gate-drain)	Qg	$V_{DD}$ = 10 V, $I_{D}$ = 800 mA,	_	1.0	_	nC
Gate-source charge 1	Q <sub>gs1</sub>	V <sub>GS</sub> = 4.5 V	_	0.12	_	
Gate-drain charge	Q <sub>gd</sub>		_	0.4	_	



## 5.5. Q1 Source-Drain Characteristics (Unless otherwise specified, Ta = 25 °C)

Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit
Diode forward voltage	(Note 1)	$V_{DSF}$	$I_D$ = -800 mA, $V_{GS}$ = 0 V	_	-0.82	-1.2	V

Note 1: Pulse measurement.

### 5.6. Q2 Static Characteristics (Unless otherwise specified, T<sub>a</sub> = 25 °C)

Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage current		I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 8 \text{ V}$	_	_	±1	μА
Drain cut-off current		I <sub>DSS</sub>	V <sub>DS</sub> = -20 V, V <sub>GS</sub> = 0 V	_	_	-1	
Drain-source breakdown voltage	·	V <sub>(BR)DSS</sub>	I <sub>D</sub> = -1 mA, V <sub>GS</sub> = 0 V	-20	_	_	V
Drain-source breakdown voltage	(Note 1)	V <sub>(BR)DSX</sub>	I <sub>D</sub> = -1 mA, V <sub>GS</sub> = 5 V	-15	_	_	
Gate threshold voltage	(Note 2)	$V_{th}$	$V_{DS} = -3 \text{ V}, I_{D} = -1 \text{ mA}$	-0.3	_	-1.0	
Drain-source on-resistance	(Note 3)	R <sub>DS(ON)</sub>	I <sub>D</sub> = -800 mA, V <sub>GS</sub> = -4.5 V	_	310	390	mΩ
			I <sub>D</sub> = -500 mA, V <sub>GS</sub> = -2.5 V	_	380	480	
			I <sub>D</sub> = -200 mA, V <sub>GS</sub> = -1.8 V	_	470	660	
			I <sub>D</sub> = -100 mA, V <sub>GS</sub> = -1.5 V	_	560	900	
			I <sub>D</sub> = -10 mA, V <sub>GS</sub> = -1.2 V	_	770	4000	
Forward transfer admittance	(Note 3)	Y <sub>fs</sub>	$V_{DS} = -3 \text{ V}, I_{D} = -100 \text{ mA}$	0.5	1.0	_	S

Note 1: If a reverse bias is applied between gate and source, this device enters  $V_{(BR)DSX}$  mode. Note that the drain-source breakdown voltage is lowered in this mode.

Note 2: Let  $V_{th}$  be the voltage applied between gate and source that causes the drain current ( $I_D$ ) to below (-1 mA for this device). Then, for normal switching operation,  $V_{GS(ON)}$  must be higher than  $V_{th}$ , and  $V_{GS(OFF)}$  must be lower than  $V_{th}$ . This relationship can be expressed as:  $V_{GS(OFF)} < V_{th} < V_{GS(ON)}$ .

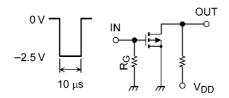
Take this into consideration when using the device.

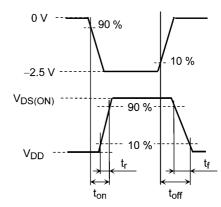
Note 3: Pulse measurement.

### 5.7. Q2 Dynamic Characteristics (Unless otherwise specified, T<sub>a</sub> = 25 °C)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Input capacitance	C <sub>iss</sub>	V <sub>DS</sub> = -10 V , V <sub>GS</sub> = 0 V,	_	100	_	pF
Reverse transfer capacitance	C <sub>rss</sub>	f = 1 MHz	_	10	_	
Output capacitance	C <sub>oss</sub>		_	16	_	
Switching time (turn-on time)	t <sub>on</sub>	V <sub>DD</sub> = -10 V, I <sub>D</sub> = -200 mA,	_	8	_	ns
Switching time (turn-off time)	t <sub>off</sub>	$V_{GS}$ = 0 to -2.5 V, $R_{G}$ = 50 $\Omega$	_	26	_	

#### 5.8. Q2 Switching Time Test Circuit





**Switching Time Test Circuit** 

Input Waveform/Output Waveform



## 5.9. Q2 Gate Charge Characteristics (Unless otherwise specified, T<sub>a</sub> = 25 °C)

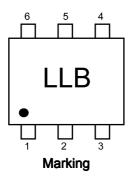
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Total gate charge (gate-source plus gate-drain)	$Q_g$	$V_{DD}$ = -10 V, $I_{D}$ = -800 mA,	_	1.6		nC
Gate-source charge 1	Q <sub>gs1</sub>	V <sub>GS</sub> = -4.5 V	_	0.2		
Gate-drain charge	$Q_{gd}$		_	0.4		

## 5.10. Q2 Source-Drain Characteristics (Unless otherwise specified, $T_a$ = 25 °C)

Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit
Diode forward voltage (N	ote 1)	$V_{DSF}$	$I_D = 800 \text{ mA}, V_{GS} = 0 \text{ V}$	_	0.9	1.2	V

Note 1: Pulse measurement.

### 6. Marking





#### 7. Characteristics Curves (Note)

#### 7.1. Q1 Characteristics Curves

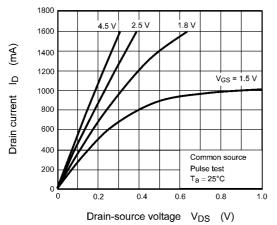


Fig. 7.1.1 I<sub>D</sub> - V<sub>DS</sub>

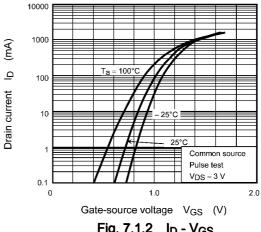


Fig. 7.1.2 I<sub>D</sub> - V<sub>GS</sub>

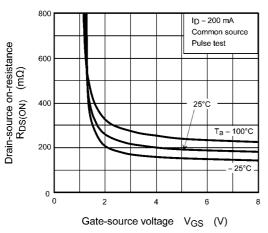


Fig. 7.1.3 R<sub>DS(ON)</sub> - V<sub>GS</sub>

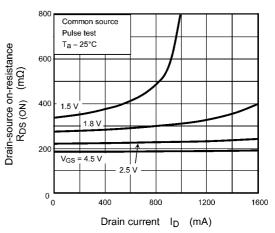


Fig. 7.1.4 R<sub>DS(ON)</sub> - I<sub>D</sub>

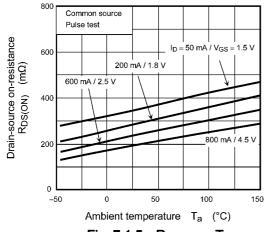


Fig. 7.1.5 R<sub>DS(ON)</sub> - T<sub>a</sub>

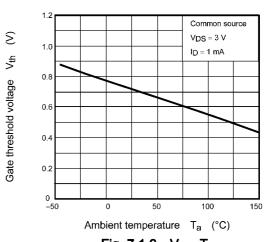


Fig. 7.1.6 V<sub>th</sub> - T<sub>a</sub>



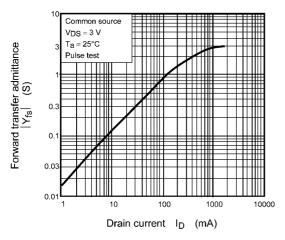


Fig. 7.1.7 |Yfs| - ID

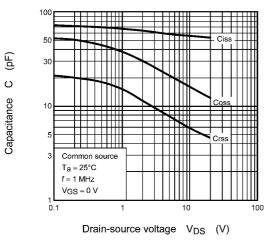


Fig. 7.1.9 C - V<sub>DS</sub>

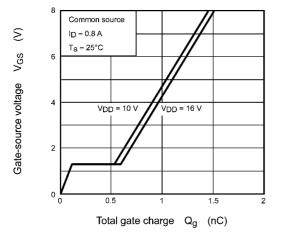


Fig. 7.1.11 Dynamic Input Characteristics

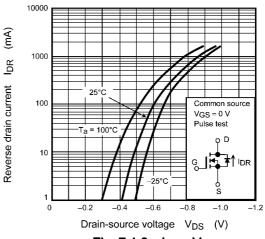


Fig. 7.1.8 I<sub>DR</sub> - V<sub>DS</sub>

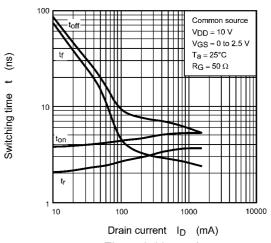


Fig. 7.1.10 t-I<sub>D</sub>

Rev.1.0



#### 7.2. Q2 Characteristics Curves

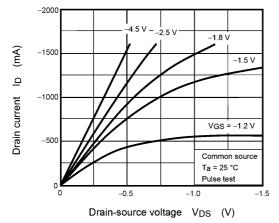
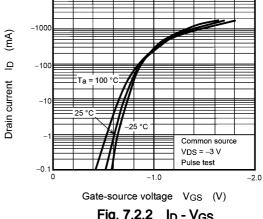


Fig. 7.2.1 I<sub>D</sub> - V<sub>DS</sub>



-10000

Fig. 7.2.2 I<sub>D</sub> - V<sub>GS</sub>

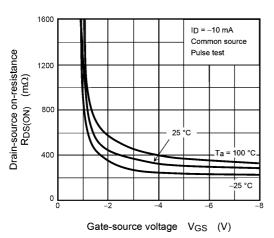


Fig. 7.2.3 R<sub>DS(ON)</sub> - V<sub>GS</sub>

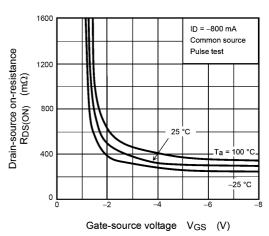


Fig. 7.2.4 R<sub>DS(ON)</sub> - V<sub>GS</sub>

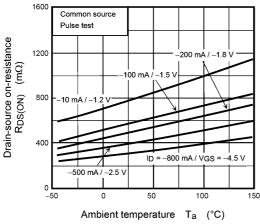


Fig. 7.2.5 R<sub>DS(ON)</sub> - T<sub>a</sub>

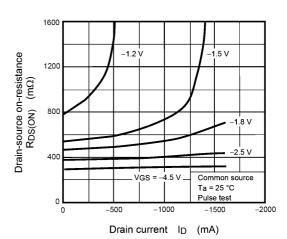


Fig. 7.2.6 R<sub>DS(ON)</sub> - I<sub>D</sub>



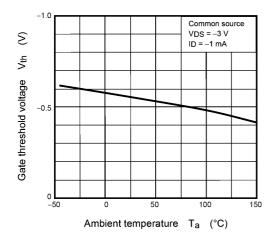


Fig. 7.2.7 Vth - Ta

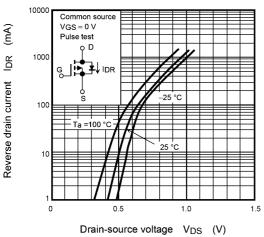


Fig. 7.2.9 I<sub>DR</sub> - V<sub>DS</sub>

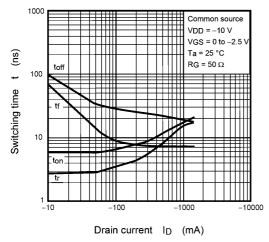


Fig. 7.2.11 t-I<sub>D</sub>

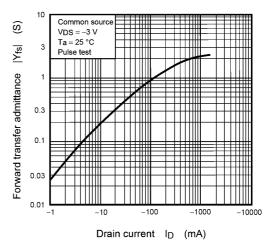


Fig. 7.2.8 |Y<sub>fs</sub>| - I<sub>D</sub>

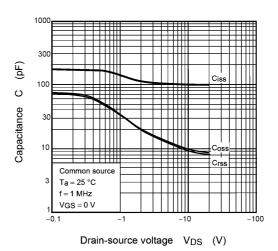


Fig. 7.2.10 C - V<sub>DS</sub>

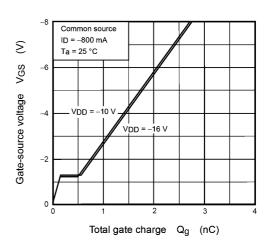


Fig. 7.2.12 Dynamic Input Characteristics



## 7.3. Characteristics Curves (Q1, Q2 Common)

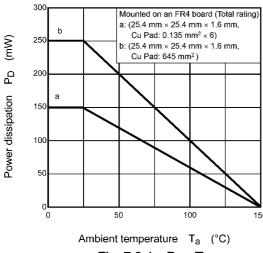


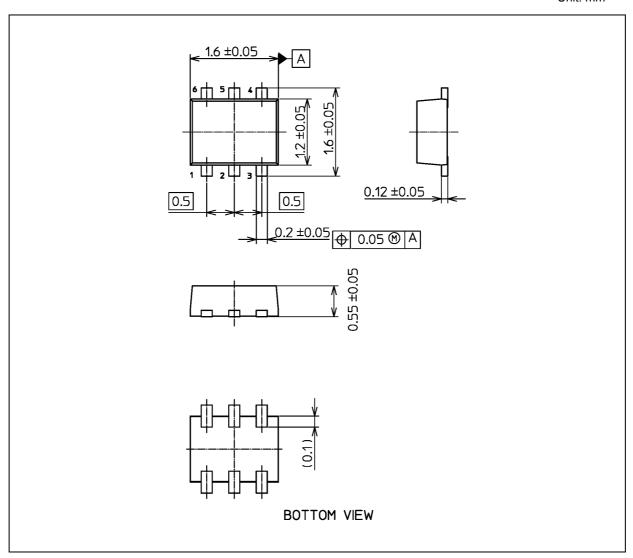
Fig. 7.3.1 P<sub>D</sub> - T<sub>a</sub>

Note: The above characteristics curves are presented for reference only and not guaranteed by production test, unless otherwise noted.



## **Package Dimensions**

Unit: mm



Weight: 3.0 mg (typ.)

	Package Name(s)
Nickname: ES6	



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